

Report No.: DL-20231120023E

TEST REPORT

MIC Optoelectronic Co., Ltd Applicant: 2nd floor, Third Building, 97# AiNan Road, LongDong, BaoLong Street, LongGang District, Address: Shenzhen, China Manufacturer: MIC Optoelectronic Co., Ltd 2nd floor, Third Building, 97# AiNan Road, LongDong, BaoLong Street, LongGang District, Address: Shenzhen, China EUT: LED Street Light Trade Mark: MSL-F200 MSL-F25, MSL-F30, MSL-F50, MSL-F60, MSL-F80, MSL-F100, MSL-F120, MSL-F150, Model Number: MSL-F180, MSL-F240, MSL-F300 Date of Receipt: Nov. 14, 2023 Test Date: Nov. 14, 2023 - Nov. 20, 2023 Date of Report: Nov. 20, 2023 Prepared By: Shenzhen DL Testing Technology Co., Ltd. 101-201, Building C, Shuanghuan, No.8, Baoqing Road, Baolong Industrial Zone, Baolong Address: Street, Longgang District, Shenzhen, Guangdong, China BS EN IEC 55015:2019+A11:2020 BS IEC 61000-3-2:2019+A1:2021, BS EN 61000-3-3:2013+A1:2019+A2:2021 Applicable BS EN 61547:2023 Standards: BS EN 61000-4-2:2009, BS EN IEC 61000-4-3:2020, BS EN 61000-4-4:2012, BS EN 61000-4-5:2014+A1:2017, BS EN 61000-4-6:2014/AC:2015, BS EN 61000-4-8:2010, BS EN IEC 61000-4-11:2020 Test Result: Pass Report Number: DL-20231120023E chaology Prepared (Engineer): HuiLian Xu Reviewer (Supervisor): Jack Bu

Approved (Manager):

Jade Yang

Approved

This test report is based on a single evaluation of one sample of above mentioned products. It is not permitted to be duplicated in extracts without written approval of Shenzhen DL Testing Technology Co., Ltd.



Report No.: DL-20231120023E

TABLE OF CONTENT

Te	st Report Declaration	Page 🤇
1.	VERSION	3
2,	TEST SUMMARY	
3.	GENERAL INFORMATION	4
4.	TEST INSTRUMENT USED	5
5.	DISTURBANCE VOLTAGES TEST	
6.	RADIATED DISTURBANCE IN 9 KHZ TO 30 MHZTEST	
7.	RADIATED DISTURBANCE	15
8.	HARMONIC CURRENT EMISSION TEST	
9.	VOLTAGE FLUCTUATIONS & FLICKER TEST	
10.	IMMUNITY TEST OF GENERAL THE PERFORMANCE CRITERIA	
11.	ELECTROSTATIC DISCHARGE IMMUNITY TEST	
12.	RF FIELD STRENGTH SUSCEPTIBILITY TEST	
13.	ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST	
14.	SURGE TEST	
15.	INJECTED CURRENTS SUSCEPTIBILITY TEST	
16.	MAGNETIC FIELD IMMUNITY TEST	
17.	VOLTAGE DIPS AND INTERRUPTIONS TEST	
18.	SETUP PHOTOGRAPHS	
19.	EUT PHOTOGRAPHS	

or.



Report No.: DL-20231120023E

VERSION

Version No.	Date	Description
× 00 ×	Nov. 20, 2023	Original
C ^e N		

TEST SUMMARY

	EMC Emission			
Standard	Test Item	Limit	Result	Remark
or cor	Disturbance voltages (CE)	O`	PASS	o ^v co
BS EN 55015	Radiated disturbance in 9kHz-30MHz (ME)		PASS	O ^L
x Dr cert	Radiated disturbance in 30MHz-1000MHz (RE)		PASS	
BS IEC 61000-3-2	Harmonic Current Emission	Class C	PASS	C°
BS EN 61000-3-3	Voltage Fluctuations & Flicker		😞 PASS 🔿	CON
	EMC Immunity			·
Section BS EN 61547	Test Item	Performance Criteria	Result	Remark
BS EN 61000-4-2	Electrostatic Discharge	С [©] В	PASS	1 ·
BS EN IEC 61000-4-3	RF electromagnetic field	A C	PASS	х х
BS EN 61000-4-4	Fast transients	B B	PASS	, Co
BS EN 61000 4 5	Surgos	в	DASS	0 - e

BS EN 61000-4-2	Electrostatic Discharge	G ^{©°} B	PASS	N.
BS EN IEC 61000-4-3	RF electromagnetic field	A S	PASS	,
BS EN 61000-4-4	Fast transients	B	PASS	, Co
BS EN 61000-4-5	Surges	В	PASS	or co
BS EN 61000-4-6	Injected Current	А	PASS	
BS EN 61000-4-8	Power Frequency Magnetic Field	A S	PASS	0
BS EN IEC 61000-4-11	Volt. Interruptions Volt. Dips	B / C / C ^{NOTE (3)}	PASS	>

NOTE:

- (1)" N/A" denotes test is not applicable in this Test Report
- (2) The power consumption of EUT is less than 75W and no Limits apply.
- (3) Voltage dip: 100% reduction Performance Criteria B
 - Voltage dip: 30% reduction Performance Criteria C
 - Voltage Interruption: 100% Interruption Performance Criteria C
- (4) Test Facility: Shenzhen DL Testing Technology Co., Ltd.
- Address: 101-201, Building C, Shuanghuan, No.8, Baoqing Road, Baolong Industrial Zone, Baolong Street, Longgang District, Shenzhen, Guangdong, China



Report No.: DL-20231120023E

3. GENERAL INFORMATION

3.1 Description of Device (EUT)

EUT: LED Street Light

Trade Mark:

AMI

Model Number:MSL-F200
MSL-F25, MSL-F30, MSL-F50, MSL-F60, MSL-F80, MSL-F100, MSL-F120,
MSL-F150, MSL-F180, MSL-F240, MSL-F300Test Model:MSL-F200Model difference:The product's different for model number and appearance color.Power Supply:Input: 220-240V~ 1.1A 50/60Hz
Output: 48V=== 3.45AWorking Frequency:Below 108MHzNOTE:

(1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.(2) The EUT's all information provided by client.

EUT

- (2) The EOT'S all information provided by C
- 3.2 Tested System Details

None.

3.3 Block Diagram of Test Set-up

AC Mains

3.4 Test Mode Description

Mode1. On Mode

3.5 Test Auxiliary Equipment

None.

3.6 Test Uncertainty Conducted Emission Uncertainty : ±2.56dB

Radiated Emission Uncertainty

±3.24dB



Report No.: DL-20231120023E

4. TEST INSTRUMENT USED

For Conducted Emission Test (843 Shielded Room)

AV					
Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
843 Shielded Room	ChengYu	843 Room	843	Sep. 20, 2022	Sep. 19, 2025
EMI Receiver	R&S	ESR	101421	Nov. 04, 2023	Nov. 03, 2024
CLISN	R&S	ENV216	102417	Nov. 04, 2023	Nov. 03, 2024
Clamp	COM-POWER	CLA-050	431072	Nov. 04, 2023	Nov. 03, 2024
3-Loop Antenna	DAZE	ZN30401	13021	Nov. 04, 2023	Nov. 03, 2024
ISN T8	Schwarzbeck	NTFM 8158	101135	Nov. 04, 2023	Nov. 03, 2024
ISN T5	Schwarzbeck	NTFM 8158	101136	Nov. 04, 2023	Nov. 03, 2024
843 Cable 1#	ChengYu	CE Cable	001	Nov. 04, 2023	Nov. 03, 2024
843 Cable 1#	ChengYu	CE Cable	002	Nov. 04, 2023	Nov. 03, 2024
		Ň			

For Radiated Emission Test (966 chamber)

Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
966 chamber	ChengYu	966 Room	966-0	Nov. 06, 2023	Nov. 05, 2026
Spectrum Analyzer	Agilent	E4408B	MY50140780	Nov. 04, 2023	Nov. 03, 2024
EMI Receiver	R&S	ESRP7	101393	Nov. 04, 2023	Nov. 03, 2024
Amplifier	Schwarzbeck	BBV9743B	00153	Nov. 04, 2023	Nov. 03, 2024
Amplifier	S EMEC	EM01G8GA	00270	Nov. 04, 2023	Nov. 03, 2024
Broadband Trilog Antenna	Schwarzbeck	VULB9162	00306	Nov. 04, 2023	Nov. 03, 2024
Horn Antenna	Schwarzbeck	BBHA9120D	02139	Nov. 04, 2023	Nov. 03, 2024
966 Cable 1#	ChengYu	966	004	Nov. 04, 2023	Nov. 03, 2024
966 Cable 2#	ChengYu	966	003	Nov. 04, 2023	Nov. 03, 2024

For Harmonic & Flicker Test (EMS --- site)

Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
Harmonics, Flicker & power Analyser	LAPLACE INSTRUMENTS	AC2000A	311370	Nov. 04, 2023	Nov. 03, 2024
AC Power Supply	MToni	HPF5010	633659	Nov. 04, 2023	Nov. 03, 2024

For Electrostatic Discharge Immunity Test (EMS --- site)

Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
ESD Tester	SCHLODER	SESD 230	17352	Nov. 04, 2023	Nov. 03, 2024



Report No.: DL-20231120023E

Tor tri Tield otrength ouseeptibility rest (iteyway - site)							
Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.		
Signal Generator	A HP	8648A	3625U00573	Apr. 12, 2023	Apr. 11, 2024		
Amplifier	A&R	500A100	17034	Apr. 12, 2023	Apr. 11, 2024		
Amplifier	A&R	100W/1000M1	17028	Apr. 12, 2023	Apr. 11, 2024		
Audio Analyzer (20Hz~1GHz)	Panasonic	2023B	202301/428	Apr. 12, 2023	Apr. 11, 2024		
Isotropic Field Probe	A&R	FP2000	16755	Apr. 12, 2023	Apr. 11, 2024		
Antenna	EMCO	3108	9507-2534	Apr. 12, 2023	Apr. 11, 2024		
Log-periodic Antenna	A&R	AT1080	16812	Apr. 12, 2023	Apr. 11, 2024		

For RF Field Strength Susceptibility Test (Keyway --- site)

For EFT /B, Surge, Voltage Dips Interruptions Test (EMS --- site)

Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
Transient Comprehensive Immunity Test System	Graphtec	HVIP16T+HCO MPACT 5	192501+192202	Nov. 04, 2023	Nov. 03, 2024
Coupling Clamp	HTEC	° 001_°	0001	Nov. 04, 2023	Nov. 03, 2024

For Injected Currents Susceptibility Test (EMS --- site)

Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
C/S Test System		RIS-6091-85	0191101	Nov. 04, 2023	Nov. 03, 2024
CDN	LIONCEL	CDN-M2-16	0191001	Nov. 04, 2023	Nov. 03, 2024
CDN		CDN-M3-16	0191002	Nov. 04, 2023	Nov. 03, 2024
Injection Clamp	Frankonia	EMCL-20	18101728-0108	Nov. 04, 2023	Nov. 03, 2024

For Magnetic Field Immunity Test (EMS --- site)

Equipment	Manufacturer	Model	Serial	Last Cal.	Next Cal.
Magnetic field Test System	LIONCEL	PMF-801C-C/ PMF-801C-T	190401	Nov. 04, 2023	Nov. 03, 2024

Other

		. / X		
Item	Name	Manufacturer	Model	Software version
1	EMC Conduction Test System	FALA	EZ_EMC	EMC-CON 3A1.1
200	EMC radiation test system	FALA	EZ_EMC	FA-03A2
3	RF test system	MAIWEI	MTS8310	2.0.0.0
4	RF communication test system	MAIWEI	MTS8200	2.0.0.0



Report No.: DL-20231120023E



5.1 Block Diagram Of Test Setup



Note: 1.Support units were connected to second LISN. 2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 cm from other units and other metal planes

Ground Plane

5.2 Test Standard and Limit

BS EN 55015

Frequency	Limits	dB(μV)
MHz	Quasi-peak Level	Average Level
0,009 to 0,05	110	ON CON
0.05 to 0.15	90 to 80*	and - at
0.15~0.50	66 ~ 56*	55 ~ 46*
0.50~5.00	56	46
5.00~30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

5.3 EUT Configuration on Test

The following equipment's are installed on conducted emission test to meet BS EN 55015 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. 5.4 Operating Condition of EUT

5.4.1 Setup the EUT and simulators as shown in Section 5.1.

5.4.2 Turn on the power of all equipment.

5.4.3 Let the EUT work in test modes and test it.

5.5 Test Procedure

The EUT is put on the table and connected to the AC mains through a Artificial Mains Network (AMN) or ISN. This provided a 50ohm coupling impedance for the tested equipment. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **BS EN 55015** regulations during conducted emission test.



Report No.: DL-20231120023E

The bandwidth of the test receiver (R&S Test Receiver ESR) is set at 10KHz. The frequency ranges from 150kHz to 30MHz is investigated.

5.6 Test Result

PASS



	X.		
	Disturbance Vol	tages Test Data	
Temperature:	24.5°C	Relative Humidity:	54%
Pressure:	1009hPa	Phase:	Line
Test Voltage:	AC 230V/50Hz	Test Mode:	Mode 1



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.181400	50.88	9.90	60.78	64.42	-3.64	QP	Р	
2	0.181400	34.72	9.90	44.62	54.42	-9.80	AVG	Р	
3	0.555000	33.21	9.33	42.54	56.00	-13.46	QP	Р	
4	0.555000	17.00	9.33	26.33	46.00	-19.67	AVG	Ρ	
5	1.351400	19.44	9.54	28.98	56.00	-27.02	QP	Р	
6	1.351400	6.44	9.54	15.98	46.00	-30.02	AVG	Р	
7	3.709400	15.86	9.81	25.67	56.00	-30.33	QP	Ρ	
8	3.709400	4.14	9.81	13.95	46.00	-32.05	AVG	Р	
9	14.455500	26.47	10.23	36.70	60.00	-23.30	QP	Р	
10	14.455500	14.77	10.23	25.00	50.00	-25.00	AVG	Ρ	
11	21.803900	23.88	10.74	34.62	60.00	-25.38	QP	Ρ	
12	21.803900	13.75	10.74	24.49	50.00	-25.51	AVG	Ρ	

Remark:Correct Factor = Cable lose + LISN insertion loss; Level = Reading + Correct factor;Margin = Level – Limit;

Report No.: DL-20231120023E



Report No.: DL-20231120023E

O ^V c ^{OV}		O ^v c ^o ^v	
	Disturbance Vol	tages Test Data	
Temperature:	24.5°C	Relative Humidity:	54%
Pressure:	1009hPa	Phase:	Neutral
Test Voltage:	AC 230V/50Hz	Test Mode:	Mode 1



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.181500	51.49	9.45	60.94	64.42	-3.48	QP	Р	
2	0.181500	34.70	9.45	44.15	54.42	-10.27	AVG	Ρ	
3	0.550500	33.15	9.38	42.53	56.00	-13.47	QP	Ρ	
4	0.550500	15.67	9.38	25.05	46.00	-20.95	AVG	Ρ	
5	1.369500	20.14	9.63	29.77	56.00	-26.23	QP	Ρ	
6	1.369500	6.08	9.63	15.71	46.00	-30.29	AVG	Р	
7	4.299000	19.08	10.04	29.12	56.00	-26.88	QP	Ρ	
8	4.299000	5.57	10.04	15.61	46.00	-30.39	AVG	Ρ	
9	11.170500	19.41	10.32	29.73	60.00	-30.27	QP	Ρ	
10	11.170500	6.92	10.32	17.24	50.00	-32.76	AVG	Ρ	
11	22.006500	23.41	10.79	34.20	60.00	-25.80	QP	Ρ	
12	22.006500	14.10	10.79	24.89	50.00	-25.11	AVG	Ρ	



6. RADIATED DISTURBANCE IN 9 KHZ TO 30 MHZTEST

6.1 Block Diagram of Test Setup



6.2 Test Standard and Limit BS EN 55015

2 N.Y	
Frequency	Limits dB(µA) 2m Loop Diameter
MHz	Quasi-peak Level
0,009 to 0,07	88
0.07 to 0.15	88 ~ 58*
0.15~3.00	58 ~ 22*
3.00~30.00	22

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

6.3 EUT Configuration on Test

The following equipment's are installed on conducted emission test to meet BS EN 55015 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. 6.4 Operating Condition of EUT

6.4.1 Setup the EUT and simulators as shown in Section 6.1.

6.4.2 Turn on the power of all equipment.

6.4.3 Let the EUT work in test modes and test it.

6.5 Test Procedure

The EUT is put on the table and connected to the AC mains through a Artificial Mains Network (AMN) or ISN. This provided a 50ohm coupling impedance for the tested equipment. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **BS EN 55015** regulations during conducted emission test.

The bandwidth of the test receiver (R&S Test Receiver ESR) is set at 10KHz.

The frequency range from 9kHz to 30MHz is investigated.

6.6 Test Result

PASS



Report No.: DL-20231120023E

				Radiated	disturba	nce (9Kł	Hz-30M⊦	lz) Test	Data			Ó
ė	Temp	perature:	24.5℃	. <) d	R	elative H	umidity:		54%	CO	
ł	Press	sure:	1009hP	a	0 ^V	P	olarizatio	n:		Х	0 ^V	- Ot
	Test `	Voltage:	AC 230	V/50Hz	× ·	Te	est Mode	:		Mode 1		
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-10	-											
-21	0.009)			C):	(MHz)			5.000	,	30.000
1	No.	Frequency (MHz)	Reading (dBuA)	Factor (dB)	Level (dBuA)	Limit (dBuA)	Margin (dB)	Detector	P/F	Remark		
	1	0.012000	-38.50	50.00	11.50	88.00	-76.50	QP	Р			
	2	0.038600	-22.65	56.56	33.91	88.00	-54.09	QP	Ρ			
	3	0.150200	-14.41	30.00	15.59	57.98	-42.39	QP	P			
	4	0.658200	-16.09	30.00	13.91	40.23	-26.32	QP	P			
	5	2.170500	-17.00	30.00	13.00	25.89	-12.89	QP	P			
	0 ~	9.753000	-10.95	30.00	13.05	22.00	-8.95	QP	P			



Report No.: DL-20231120023E

			Radiated	l disturba	nce (9KH	lz-30MH	lz) Test	Data				
Temp	perature:	Re	elative H	umidity:		54%						
Pres	sure:	1009hP	а		Po	larizatio	n:		Y	AV.	1º	
Test	Voltage:	AC 230	V/50Hz			st Mode	:		Mode 1	\sim	Ç [©] x	
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No.	Frequency (MHz)	Reading (dBuA)	Factor (dB)	Level (dBuA)	Limit (dBuA)	Margin (dB)	Detector	P/F	Remark			
1	0.027400	-23.90	58.19	34.29	88.00	-53.71	QP	P				
2	0.062500	-36.46	53.09	16.63	88.00	-71.37	QP	P				
3	0.232600	-15.81	30.00	14.19	52.73	-38.54	QP	P				
4	0.829500	-17.95	30.00	12.05	37.45	-25.40	QP	P				
5 *	5.374500	-14.28	30.00	15.72	22.00	-6.28	QP	P				
6	23.310800	-14.61	30.00	15.39	22.00	-6.61	QP	P				



Report No.: DL-20231120023E

			Radiated	l disturba	nce (9KH	lz-30MH	lz) Test	Data			
Temp	erature:	24.5 ℃	<	Y c	Re	elative H	umidity:		54%	-0	0
Press	sure:	1009hP	а	Polarization:			Z		N.		
Test \	Voltage:	AC 230	V/50Hz	\bigcirc	Te	st Mode	:		Mode 1	\sim	, Co
.00	dBuA	0 ^V	~ e ^t	. <) ² _C	Ø ×		04	~ 614	• • • • • • • • • • • • • • • • • • •	, <u>,</u> , , , , , , , , , , , , , , , , ,
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0.009		(J ⁻			(MHz)				5.000		30.0
lo.	Frequency (MHz)	Reading (dBuA)	Factor (dB)	Level (dBuA)	Limit (dBuA)	Margin (dB)	Detector	P/F	Remark		
	0.026900	-27.78	58.26	30.48	88.00	-57.52	QP	Ρ			
2	0.090700	-41.31	55.32	14.01	77.80	-63.79	QP	P			
3	0.267000	-15.83	30.00	14.17	51.07	-36.90	QP	P			
ł	0.829500	-16.45	30.00	13.55	37.45	-23.90	QP	P			
5	3.183100	-17.30	30.00	12.70	22.00	-9.30	QP	P			
*	14,167600	-16.18	30.00	13.82	22.00	-8.18	QP	P			



- 7. RADIATED DISTURBANCE IN 30MHZ TO 1000 MHZTEST
- 7.1 Block Diagram of Test Setup





7.2 Test Standard and Limit BS EN 55015

Frequency (MHz)	Qua	isi-peak limits at 3m dB(μV/m)	
30-230	Or Cor	40	\bigcirc^{\vee}
230-1000	Or cor	47	

Remark:

- (1) The smaller limit shall apply at the cross point between two frequency bands.
- (2) Distance refers to the distance in meters between the measuring instrument, antenna and the
- closed point of any part of the device or system.
- 7.3 EUT Configuration on Test
 - The BS EN 55015 regulations test method must be used to find the maximum emission during radiated emission test.
 - The configuration of EUT is the same as used in conducted emission test.
 - Please refer to Section 5.3.
 - 7.4 Operating Condition of EUT
 - Same as conducted emission test, which is listed in Section 5.4 except the test set up replaced as
- Section 6.2. 7.5 Test Procedure
 - 1) The radiated emissions test was conducted in a semi-anechoic chamber.



2) The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.

3) Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emissions spectrum plots of the EUT.

4) The frequencies of maximum emission were determined in the final radiated emissions measurement. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance. Measurements were performed for both horizontal and vertical antenna polarization.

5) The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz.

6) The frequency range from 30MHz to 1000MHz is checked.

7.6 Test Result

PASS



Report No.: DL-20231120023E

				R	Radia	ated	d b	isturbance (30	MHz-′	1000	MHz) Te	est Data						
Те	mperatur	e:	24.	5°C			Ó	V cot	Relat	tive I	Humidity	<i>'</i> :	54%	Ý	çê	Ķ.		
Pro	essure:		100	1009hPa				Pola	rizati	on:		Horizo	ntal	~~~	,	X		
Те	st Voltage	e:	AC	230	V/50)Hz		0	Test	Mod	e:		Mode	1		Ģ	9	>
0.0	 dBu¥/n	u N		04	, ,	_ 0	j.	\Diamond^{\vee}	, CON		£	O ^{1/}	- of		\diamond		, Ç	. 9`
0																		
0																		
0															BS	EN5	5015	
0															Mar	gin -C	i dB	
ព																		
20							3	4		5	Malm	, G	to the late	hereer	with a service	m	set.	n Mad
0	Lugerthhand	My AN A WAY	Marchan W	hand	Å	WAR	1. M	www.m.w.	and work	/" Y	a ar ny Ar ah	- white						
	1 11																	

		_		F	Read	ding	Cor	rect	Me	easur	e- ,	 Ma			
30.000		6	0.00					(MHz)		3	00.00			1000.0)00 🗹
0.0															

	No.	Mk.	Freq.	Level	Factor	ment	Limit	Margin	
			MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
	1		58.2030	28.17	-12.79	15.38	40.00	-24.62	QP
	2		76.7808	33.07	-16.85	16.22	40.00	-23.78	QP (
	3		91.1746	35.17	-16.95	18.22	40.00	-21.78	QP
	4	1	55.9101	35.94	-17.47	18.47	40.00	-21.53	QP
	5	* 2	213.7634	35.69	-14.19	21.50	40.00	-18.50	QP
_	6	3	337.2155	35.88	-10.81	25.07	47.00	-21.93	QP

Remark:

Correct Factor=Cable loss+Antenna factor-Preamplifier

MeasurementLevel = Reading Level + Correct Factor; Margin = Measurement Level-Limit;



Report No.: DL-20231120023E

O* ~0			
	Radiated Disturbance (30	MHz-1000MHz) Test Data	
Temperature:	24.5°C	Relative Humidity:	54%
Pressure:	1009hPa	Polarization:	Vertical
Test Voltage:	AC 230V/50Hz	Test Mode:	Mode 1



Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin	
	MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
	48.6719	31.01	-13.29	17.72	40.00	-22.28	QP
	72.0843	36.38	-15.84	20.54	40.00	-19.46	QP
*	90.5374	44.94	-16.98	27.96	40.00	-12.04	QP
	140.8351	34.30	-17.44	16.86	40.00	-23.14	QP
	217.5443	35.75	-14.03	21.72	40.00	-18.28	QP
	744.8661	33.95	-3.15	30.80	47.00	-16.20	QP
	Mk.	Mk. Freq. MHz 48.6719 72.0843 * 90.5374 140.8351 217.5443 744.8661	Mk. Freq. Reading Level MHz dBuV 48.6719 31.01 72.0843 36.38 * 90.5374 44.94 140.8351 34.30 217.5443 35.75 744.8661 33.95	Mk. Freq. Reading Level Correct Factor MHz dBuV dB 48.6719 31.01 -13.29 72.0843 36.38 -15.84 * 90.5374 44.94 -16.98 140.8351 34.30 -17.44 217.5443 35.75 -14.03 744.8661 33.95 -3.15	Mk. Freq. Reading Level Correct Factor Measure- ment MHz dBuV dB dBuV/m 48.6719 31.01 -13.29 17.72 72.0843 36.38 -15.84 20.54 * 90.5374 44.94 -16.98 27.96 140.8351 34.30 -17.44 16.86 217.5443 35.75 -14.03 21.72 744.8661 33.95 -3.15 30.80	Mk. Freq. Reading Level Correct Factor Measure ment Limit MHz dBuV dB dBuV/m dB/m 48.6719 31.01 -13.29 17.72 40.00 72.0843 36.38 -15.84 20.54 40.00 * 90.5374 44.94 -16.98 27.96 40.00 140.8351 34.30 -17.44 16.86 40.00 217.5443 35.75 -14.03 21.72 40.00 744.8661 33.95 -3.15 30.80 47.00	Mk. Freq. Reading Level Correct Factor Measure ment Limit Margin MHz dBuV dB dBuV/m dB/m dB 48.6719 31.01 -13.29 17.72 40.00 -22.28 72.0843 36.38 -15.84 20.54 40.00 -19.46 * 90.5374 44.94 -16.98 27.96 40.00 -12.04 140.8351 34.30 -17.44 16.86 40.00 -23.14 217.5443 35.75 -14.03 21.72 40.00 -18.28 744.8661 33.95 -3.15 30.80 47.00 -16.20

Remark:

Correct Factor=Cable loss+Antenna factor-Preamplifier

MeasurementLevel = Reading Level + Correct Factor; Margin = Measurement Level-Limit;



Report No.: DL-20231120023E

8. HARMONIC CURRENT EMISSION TEST

8.1 Block Diagram of Test Setup



8.2 Test Standard

BS IEC 61000-3-2

8.3 Operating Condition of EUT

Setup the EUT as shown in Section 8.1.

Turn on the power of all equipment.

Let the EUT work in test mode and test it.

8.4 Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

8.5 Test Results

PASS



Report No.: DL-20231120023E

EUT: LED Street Light		Operator:
Test category: IEC/EN 61000-	3-2:2019+A1:2021 Class C>25W	Model/Type:MSL-F200
Measurement standard: IEC	\$1000-4-7 Ed2:1:2009	Serial number:
Test date:2023-11-17	Start time: 16:18:44	End time: 16:21:22
Test duration (sec):150		
Describe:		

Test Result: pass Source qualification(Power Off Load): Idle - Pass Current & voltage waveforms



Harmonics and Class C limit line (>25W)



Harmonics Histogram



Report No.: DL-20231120023E

EUT: LED	Street Light				Operat	or:	
Test cate	gory: IEC/EN 610	000-3-2:2019+	A1:2021 Class	s C>25W	Model/Type: N	ISL-F200	
Measure	ment standard: I	EC 61000-4-7	Ed2:1:2009		Serial number	:	
Test date	:2023-11-17	Start tin	ne: 16:18:44	End	d time: 16:21:2	2	
Test dura	tion (sec):150						
Describe	:						
Test Res	ult: pass	Source qual	ification(Pow	er Off Load): Id	le - Pass		
THC(mA)	· 22 700	- THD(%). 2 6	PO	HC(mA):11 500	POHC	Limit(mA)-82.8	249
	. 22.700	- 1110(70). 2.0	10	no(inA). 11.000	1 one	Ennid(IIIA).02.0	
Paramete	V_RMS (Volts): I_RMS(A): Power (Watts):	test: 230.0 0.9 197.0	Frequen Crest Fa F	ncy(Hz): 50.0 ctor: 1.413 Power Factor:	0.980		
Harm#	Harms(filtered) (mA)	Limit (mA)	Harms(avg) (mA)	100%Limit	Harms(max) (mA)	150%Limit	Status
2	0.000	17,466	0.400	2,290	0.700	2.672	Pass
3	10.000	235.791	10.200	4.326	10.400	2.940	Pass
4	0.000	•	0.200	•	0.300	-	N/A
5	8.900	87.330	9.000	10.306	8.900	6.794	Pass
6	0.000	-	0.200	-	0.300		N/A
6	6.800	61.131	0.900	11.287	0.300	1.143	Pass N/A
ğ	5 700	43 665	5 600	12 825	5 700	8 703	Pass
10	0.000		0.100	-	0.300	-	N/A
11	5.700	26.199	5.600	21.375	5.700	14.504	Pass
12	0.000	-	0.100	-	0.000	-	N/A
13	5.300	26.199	5.600	21.375	5.700	14.504	Pass
14	0.000		0.000	·	0.000		N/A
15	2.100	26.199	2.000	7.634	2.100	5.344	Pass
16	0.300	26 199	0.200	19 702	0.300	- 12 723	N/A Pass
12	4.600	26.155	4.500	10.703	0.300	12.125	N/A
19	6 100	26 199	6 300	24 047	6 400	16,286	Pass
20	0.000	-	0.100	-	0.300	-	N/A
21	2.800	26.199	2.900	11.069	2.800	7.125	Pass
22	0.000	-	0.000	-	0.000	•	N/A
23	3.500	26.199	3.600	13.741	3.900	9.924	Pass
24	0.000	-	0.100	47 470	0.300	11 705	N/A Bass
25	4.300	26.199	4.500	17.176	4.600	11.705	N/A
27	3,900	26,199	4,100	15.649	4.300	10,942	Pass
28	0.000	-	0.000	-	0.000	-	N/A
29	3.900	26.199	4.000	15.268	3.900	9.924	Pass
30	0.000	-	0.100	-	0.000	-	N/A
31	2.800	26.199	3.000	11.451	3.200	8.143	Pass
32	0.000		0.100	-	0.300	-	N/A
33	2.100	26.199	2.100	8.016	2.100	5.344	Pass
35	4 600	26 199	4 700	17 940	4 600	11 705	Pass
36	0.000	-	0.100	-	0.300	-	N/A
37	3.900	26.199	3.800	14,504	3,900	9.924	Pass
38	0.000	•	0.000		0.000	-	N/A
39	1.400	26.199	1.500	5.725	1.400	3.562	Pass
40	0.000	-	0.100	-	0.300	-	N/A

Note: All harmonics are below the minimum limits and are ignored.



Report No.: DL-20231120023E

9. VOLTAGE FLUCTUATIONS & FLICKER TEST

9.1 Block Diagram of Test Setup

Same as Section 8.1.

9.2 Test Standard

BS EN 61000-3-3

9.3 Operating Condition of EUT

Same as Section 8.3. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

F	licker Test Limit	
	Test items	Limits
	Pst	1.0
	dc dc	3.3%
	Tmax	4.0%
)	dt die	Not exceed 3.3% for 500ms

9.4 Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

9.5 Test Results

	Flicker Te	st Data		
Temperature:	24.5 ℃	Rel	ative Humidity:	54%
Test Voltage:	AC 230V/50Hz		Test Mode:	Mode 1
Voltage Fluctuation		2	َ 🗸 Limit 🔨	Value
Relative Voltage (Change Characteristic Tmax (dc > 3	\$%)	500ms	0ms
St. V			4%	0.00
Ma	aximum Relative Voltage	N.	6%	A A
C ^O X	Change dinax	, ,	7%	
Relative S	Steady-state Voltage Change dc	, Cor	3.3%	0.00
))	C.O.	
Flicker	A O' CO'		Limit	Value
Shor	t-term Flicker Indicator Pst	\sim	1.0	0.063
× Yon	n-term Elicker Indicator Plt	<	0.65	3. J.



10. IMMUNITY TEST OF GENERAL THE PERFORMANCE CRITERIA

Product Standard	BS EN 61547
CRITERION A	During the test, no change of the lumimous intensity shall be observed and the regulating control, if any, shall operate during the test as intended.
	During the test the luminous intensity may change to any value. After the test the luminous intensity shall be restored to its initial value within 1 min.
	Regulating controls need not function during the test, but after the test the mode of the control shall be the same as before the test provided that during the test no mode changing commands were given.
OL OL Cert	During and after the test any change of the luminous intensity is allowed and the lamp(s) may be extinguished. After the test, within 30 min, all functions shall return to normal if necessary by temporary interruption of the mains supply
CRITERION C	Additional requirement for lighting equipment incorporating a starting device: After the test the lighting equipment is switched off. After half an hour it is switched on again. The lighting equipment shall start and operate as intended.



Report No.: DL-20231120023E

11. ELECTROSTATIC DISCHARGE IMMUNITY TEST

11.1 Block Diagram of Test Setup



11.2 Test Standard

BS EN 61547, BS EN 61000-4-2

- 11.3 Severity Levels and Performance Criterion
 - Severity Level: 3 / Air Discharge: ±8KV

Level: 2 / Contact Discharge: ±4KV

Performance criterion: B

11.4 Test Procedure

- a. Electrostatic discharges were applied only to those points and surfaces of the Product that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the Product.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the Product as fast as possible (without causing mechanical damage) to touch the Product. After each discharge, the ESD generator was removed from the Product and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling
 Plane at points on each side of the Product. The ESD generator was positioned vertically at a distance
 of 0.1 meters from the Product with the discharge electrode touching the HCP.



- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the Product were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the Product.
- 11.5 Test Results

PASS

		Electros	static Dis	charg	je Test Da	ata			
Tempera	ture:	25.1 ℃	N.		Humidit	y:		55%	, Č
Power Su	ipply:	AC 230V/50	Hz		Test Mod	de:	\sim	Mode	1 🚴
Discharge Method	Disc	harge Position	Voltag (±kV)	e)	Min. N Discha pola (Each	No. of rge per arity Point)	Requi	ired <	Result
Or and Co	Conducti	ve Surfaces	2, 4)`	0° 1	0	В	Š	Pass
Discharge	Indirect [Discharge HCP	2, 4	\Diamond	đ	0	В	Č,	Pass
Discharge	Indirect [Discharge VCP	2, 4		01/1	* م	В		Pass
Air Discharge	Slots, Ap Insulating	ertures, and g Surfaces	2, 4, 8	3	4	0	В	\diamond	Pass
Note: N/A	\diamond	G ^o C		\mathcal{O}	8	\bigcirc	Cor		



Report No.: DL-20231120023E

12. RF FIELD STRENGTH SUSCEPTIBILITY TEST

12.1 Block Diagram of Test Setup



12.2 Test Standard

BS EN 61547, BS EN IEC 61000-4-3

12.3 Severity Levels and Performance Criterion

Severity Level 2, 3V / m Performance criterion: A

12.4 Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

All the scanning conditions are as follows:

Condition of Test Fielded Strength Radiated Signal Scanning Frequency Dwell time of radiated Waiting Time Remarks 3 V/m (Severity Level 2) Modulated 80 – 1000 MHz 0.0015 decade/s 1 Sec.



12.5 Test Results

PASS

		R/S 1	fest Data				
Temperature:	25.1℃	\diamond	Humidity	y:		55%	\diamond
Power Supply:	AC 230V/50Hz		Test Mod	le:		Vlode 1	
Criterion:	A	A				1 %	- OK
Frequency (MHz)	Position	Field	l Strength (V/m)	R	equired Level	04	Result
80 – 1000	Front, Right, Back, Left	OL	3 cort	2	A Cer	Cott	Pass
Note: N/A	OV - of		V jo	0	× OV	~ 0	



Report No.: DL-20231120023E

13. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

13.1 Block Diagram of EUT Test Setup

For input a.c. / d.c. power port:



Ground Reference Plane

For signal lines and control lines:

EFT Generator



Ground Reference Plane

13.2 Test Standard

BS EN 61547, BS EN 61000-4-4

13.3 Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS

Performance criterion: B

13.4 Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.



Report No.: DL-20231120023E

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13.5 Test Results

PASS

Temperature:	24.5°C	est Data	05	3%
Power Supply :	AC 230V/50Hz	Test Mode:	Mo	de 1
Coupling Line	Test Voltage (kV)	100 N	Performance Criterion	Result
Get L ON	±0.5, 1		O'B Cert	PASS
N N	±0.5, 1	Or Cert	B of	PASS
L-N	±0.5, 1		B	PASS

or.



Report No.: DL-20231120023E

14. SURGE TEST





Ground Reference Plane

14.2 Test Standard

BS EN 61547, BS EN61000-4-5

14.3 Severity Levels and Performance Criterion

Severity Level: Line to Line, Level 2 at 1KV;

Severity Level: Line to Earth, Level 3 at 2KV.

Performance criterion: B

14.4 Test Procedure

1) Set up the EUT and test generator as shown on section 14.1

2) For line-to-line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.

3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.

4) Different phase angles are done individually.

5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.

6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

14.5 Test Result

PASS

Surge Test Data									
Temperature:		24.5 ℃	Humidity:		- A	53%			
Power Sup	oply : AC 230V/50Hz Test Mode:		est Mode:		Mode 1	\diamond_{r}			
Location	Polar	ity	Phase Angle	No	of se	Pulse Voltage (KV)	Perfor Crit	rmance erion	Result
🔆 L-N 🛇	¥.		90	5 کې	<	0.5,1		В	Pass
L-N	\diamond	(270	5	Y.	0.5,1	(В	Pass
Note: N/A		d'	- oft		, 0) x	0 ¹	- of	\sim	, Co



Report No.: DL-20231120023E

15. INJECTED CURRENTS SUSCEPTIBILITY TEST

15.1 Block Diagram of EUT Test Setup For input a.c. / d.c. power port:



For signal lines and control lines:



Ground Reference Plane

15.2 Test Standard

BS EN 61547, BS EN61000-4-6

15.3 Severity Levels and Performance Criterion

Severity Level 2: 3V(rms), 150KHz $\,\sim\,$ 80MHz/230MHz

Performance criterion: A

15.4 Test Procedure

1) Set up the EUT, CDN and test generator as shown on section 15.1

2) Let EUT work in test mode and measure.

3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).

4) The disturbance signal described below is injected to EUT through CDN.

5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.

6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the

disturbance signal 80% amplitude modulated with a 1KHz sine wave

7) The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency



0

value.

8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

15.5 Test Result

PASS

		(CS Test Data				
Tempera	ature:	24	Humic	lity: 🔗	53%		
Power Sup	oply :	AC 23	Test Mode:		Mode 1		
Frequency Range (MHz)	Injected Position	Strength	Modulation Signal	Freq. Step	Perform: Criteri	ance on	Result
0.15 ~ 80	AC Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	A	Q	Pass
0.15~80	DC Line, Signal Line	3V(rms), Unmodulated	AM 80%, 1kHz sine wave	1%	or col	o ^t	- All
Note: N/A	C ^o x	ON CO		-0" X.	OV	0	



Report No.: DL-20231120023E

16. MAGNETIC FIELD IMMUNITY TEST

16.1 Block Diagram of EUT Test Setup



Ground Reference Support

16.2 Test Standard

BS EN 61547, BS EN61000-4-8

16.3 Severity Levels and Performance Criterion

Severity Level 2: 3A/m

Performance criterion: A

16.4 Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m) and shown in Section 16.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

16.5 Test Result

PASS

MS Test Data							
Temperature: 24.5		°C C	Humidity		53%		
Power Supply :	AC 230\	//50Hz	Test Mode: Mod		Node 1		
Test specification	Units	Duration	Coil Orientation	Performance Criterion	Result		
	\sim \circ	Cer	X	A	PASS		
3	🚬 A/m 🔗	5 Min	Y	Α	PASS		
or of Or	Cox .	or of	Z	A	PASS		
Note: N/A	Cor		X O	CONT			



Report No.: DL-20231120023E

17. VOLTAGE DIPS AND INTERRUPTIONS TEST

17.1 Block Diagram of EUT Test Setup



17.2 Test Standard

BS EN 61547, BS EN IEC 61000-4-11

17.3 Severity Levels and Performance Criterion Input and Output AC Power Ports.

Voltage Dips.

☑ Voltage Interruptions.

			- 23			
Environmental	Test	Lipito	Phase	Performance		
Phenomena	Specification		Angle	Criterion		
Voltage Dips	70 10	% Reduction period	0°, 180°	C		
Voltage Interruptions	0	% Reduction	0°, 180°	° ⊖ø [¢] B		

17.4 Test Procedure

- 1) Set up the EUT and test generator as shown on section 17.1
 - 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.



Report No.: DL-20231120023E

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- 17.5 Test Result
 - PASS

Please refer to the fol	lowing page.	cent or or	or of a). Cert
	DIPS	Test Data		
Temperature:	24.5 ℃	Humidity:	53%	
Power Supply :	AC 230V/50Hz	Test Mode:	Mode	ભૈ
Environmental Phenomena	Test Specification	Units Units	Performance Criterion	Result
Voltage Dips	70 10	% Reduction period	or cost	Pass
Voltage Interruptions	00.5	% Reduction period	В	Pass



Report No.: DL-20231120023E

18. SETUP PHOTOGRAPHS







Report No.: DL-20231120023E



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Report No.: DL-20231120023E





Report No.: DL-20231120023E

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Report No.: DL-20231120023E

19. EUT PHOTOGRAPHS







Report No.: DL-20231120023E





Report No.: DL-20231120023E





***** END OF REPORT *****